



TEST REPORT

Report number : JPD-TR-18163-0

Issue date : October 1, 2018

The device, as described herewith, was tested pursuant to applicable test procedure and complies with the requirements of,

FCC Part 22 Subpart H

The test results are traceable to the international or national standards.

Applicant	:	KYOCERA Corporation
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Equipment under test (EUT)	:	Mobile Phone
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Model number	:	JA28
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FCC ID	:	JOYJA28
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Date of test	:	August 2, 3, 20, 22, 23, 24, 28, 2018
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Test place	:	TÜV SÜD Zacta Ltd. Yonezawa Testing Center 5-4149-7, Hachimanpara, Yonezawa-shi, Yamagata, 992-1128 Japan Phone: +81-238-28-2881 Fax: +81-238-28-2888
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Test results	:	Complied
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Due to merger of TÜV SÜD Japan Ltd. and TÜV SÜD Zacta Ltd. on October 1st, 2018, this test report was issued by TÜV SÜD Japan Ltd.

The results in this report are applicable only to the equipment tested.

This report shall not be re-produced except in full without the written approval of TÜV SÜD Japan Ltd.

This test report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, ILAC-MRA, or any agency of the federal government.

Tested by : Tadahiro Seino Taiki Watanabe

Tadahiro Seino

Taiki Watanabe

Approved by : Hiroaki Suzuki

Hiroaki Suzuki

Deputy Manager of RF Group



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1. Summary of Test

1.1 Purpose of test

It is the original test in order to verify conformance to FCC Part 22 Subpart H.

1.2 Standards

CFR47 FCC Part 22 Subpart H

1.2.1 Test Methods

KDB 971168 D01 Power Meas License Digital Systems v03 r01
 ANSI/TIA/EIA-603-D-2010

1.2.2 Deviation from standards

None

1.3 List of applied test to the EUT

Test items Section	Test items	Condition	Result
2.1046	Conducted Output Power	Conducted	PASS Note 1
22.913(a)	Effective Radiated Power	Radiated	PASS
22.917(a) 2.1049	Occupied Bandwidth	Conducted	PASS
22.917(a) 2.1051	Band Edge Spurious and Harmonic at Antenna Terminal	Conducted	PASS
22.917(a) 2.1053	Radiated emissions and Harmonic Emissions	Radiated	PASS
22.355 2.1055	Frequency Stability	Conducted	PASS

Note 1: Refer to RF Exposure Report (Test Report_SAR)

1.3.1 Test set up

Table-Top

1.4 Modification to the EUT by laboratory

None

2. Equipment Under Test

2.1 General Description of equipment

EUT is the Mobile Phone.

2.2 EUT information

Applicant	:	KYOCERA Corporation Yokohama Office 2-1-1 Kagahara, Tsuzuki-ku Yokohama-shi, Kanagawa, Japan Phone: +81-45-943-6253 Fax: +81-45-943-6314
Equipment under test	:	Mobile Phone
Trade name	:	Kyocera
Model number	:	JA28
Serial number	:	N/A
EUT condition	:	Pre-Production
Power ratings	:	Battery: DC 3.8V
Size	:	(W) 48.0mm × (D) 14.0mm × (H) 138.0mm
Environment	:	Indoor and Outdoor use
Operating environment	:	Temperature: 5°C to 35°C Humidity: 35% to 85%
RF Specification	:	
Frequency of Operation	:	Up Link GSM850: 824.2-848.8MHz WCDMA Band V: 826.4-846.6MHz
		Down Link GSM850: 869.2-893.8MHz WCDMA Band V: 871.4-891.6MHz
Modulation type	:	GSM850: GMSK WCDMA Band V: QPSK, 16QAM
Emission designator	:	GSM850: 239KGXW WCDMA Band V: 4M14F9W
Effective Radiated Power (E.R.P.)	:	GSM850: 1.995W (33.0dBm) WCDMA Band V: 0.2239W (23.5dBm)
Antenna type	:	Internal antenna
Antenna gain	:	GSM850: -1.0dBi WCDMA Band V: -1.0dBi

2.3 Variation of the family model(s)

Not applicable

2.4 Description of Test mode

The EUT had been tested under operating condition.
 There are three channels have been tested as following:

Band	Channel	Frequency
GSM850	128	824.2MHz
	190	836.6MHz
	251	848.8MHz
WCDMA Band V	4132	826.4MHz
	4183	836.6MHz
	4233	846.6MHz

The field strength of spurious emissions was measured at each position of all three axis X, Y and Z to compare the level, and the maximum noise.

The worst emission was found in Z axis (GSM850 and WCDMA Band V) and the worst case recorded.

3. Configuration of equipment

3.1 Equipment(s) used

No.	Equipment	Company	Model No.	Serial No.	FCC ID / DoC	Comment
1	Mobile Phone	KYOCERA	JA28	N/A	JOYJA28	EUT

3.2 System configuration

1. Mobile Phone
(EUT)

Note1: Numbers assigned to equipment on this diagram correspond to the list in "3.1 Equipment(s) used".

4. Effective Radiated Power

4.1 Measurement procedure

[FCC 22.913(a)]

<Step 1>

The EUT and support equipment are placed on a 1 meter x 1 meter surface, 0.8 meter height styrene foam table. Radiated emission measurements are performed at 3 meter distance with the broadband antenna (Log periodic antenna). The antenna is positioned both the horizontal and vertical planes of polarization and height is varied 1 to 4 meters and stopped at height producing the maximum emission.

The turntable is rotated by 360 degrees and stopped at azimuth of producing the maximum emission.

<Step 2>

The substitution antenna is replaced by the transmitter antenna (EUT).

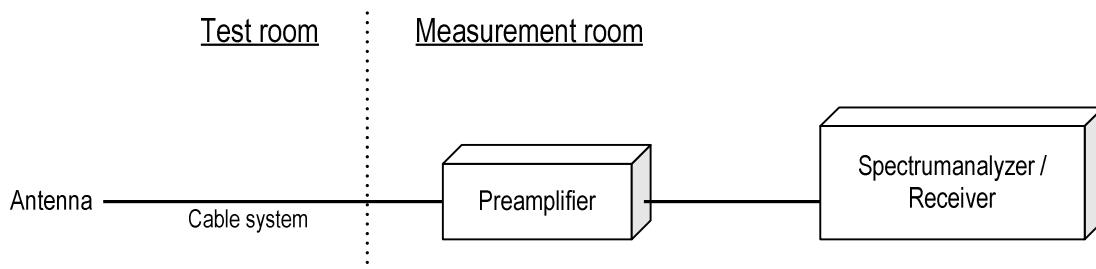
The frequency of the signal generator is adjusted to the measurement frequency.

Level of the signal generator is adjusted to the level that is obtained from step 1, and record the emission level of signal generator.

The spectrum analyzer is set to;

- a) Span = 1.5 times the OBW
- b) RBW = 1-5% of the expected OBW, not to exceed 1MHz
- c) VBW \geq 3 x RBW
- d) Number of sweep points \geq 2 x span / RBW
- e) Sweep time = auto-couple
- f) Detector = RMS (power averaging)
- g) If the EUT can be configured to transmit continuously (i.e., burst duty cycle \geq 98%), then set the trigger to free run.
- h) If the EUT cannot be configured to transmit continuously (i.e., burst duty cycle < 98 %), then use a sweep trigger with the level set to enable triggering only on full power bursts and configure the EUT to transmit at full power for the entire duration of each sweep. Ensure that the sweep time is less than or equal to the transmission burst duration.
- i) Trace average at least 100 traces in power averaging (i.e., RMS) mode.
- j) Compute the power by integrating the spectrum across the OBW of the signal using the instrument's band power measurement function, with the band limits set equal to the OBW band edges. If the instrument does not have a band power function, then sum the spectrum levels (in linear power units) at intervals equal to the RBW extending across the entire OBW of the spectrum.

- Test configuration



4.2 Calculation method

Result(ERP) = Ant. Input - Cable loss + Antenna Gain

Margin = Limit – Result (ERP)

Example:

Limit @ 836.6MHz : 38.4dBm

Ant. Input = 33.3dBm Cable loss = 0.7dB Ant. Gain = -10.7dBd

Result = 33.3 - 0.7 + (-10.7) = 21.9dBm

Margin = 38.45 – 21.9= 16.55dB

4.3 Limit

7 W (38.45dBm)

4.4 Test data

Date : August 2, 2018
 Temperature : 24.3 [°C]
 Humidity : 51.6 [%]
 Test place : 3m Semi-anechoic chamber

Test engineer : Taiki Watanabe

Date : August 28, 2018
 Temperature : 20.6 [°C]
 Humidity : 67.2 [%]
 Test place : 3m Semi-anechoic chamber

Test engineer : Tadahiro Seino

[GSM850]

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	824.2	-11.2	40.5	0.8	-6.8	33.0	38.45	5.5
H	836.6	-12.1	40.5	0.8	-6.8	32.9	38.45	5.5
H	848.8	-12.6	40.1	0.8	-6.8	32.6	38.45	5.9

[WCDMA Band V]

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	826.4	-12.0	31.0	0.8	-6.8	23.5	38.45	15.0
H	836.6	-12.0	30.9	0.8	-6.8	23.3	38.45	15.1
H	846.6	-12.8	30.8	0.8	-6.8	23.3	38.45	15.2

5. Occupied Bandwidth

5.1 Measurement procedure

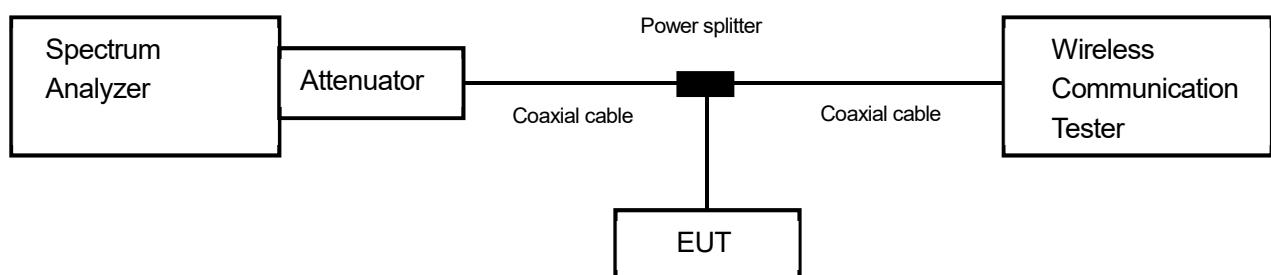
[FCC 22.917(a), 2.1049]

The Occupied bandwidth was measured with a spectrum analyzer connected to the antenna terminal. The spectrum analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth.

The spectrum analyzer is set to;

- a) RBW = 1-5% of the expected OBW & VBW $\geq 3 \times$ RBW
- b) Detector = Peak
- c) Trace mode = Max hold
- d) Sweep time = auto-couple

- Test configuration



5.2 Limit

None

5.3 Measurement result

Date : August 3, 2018
 Temperature : 24.9 [°C]
 Humidity : 54.1 [%]
 Test place : Shielded room No.4

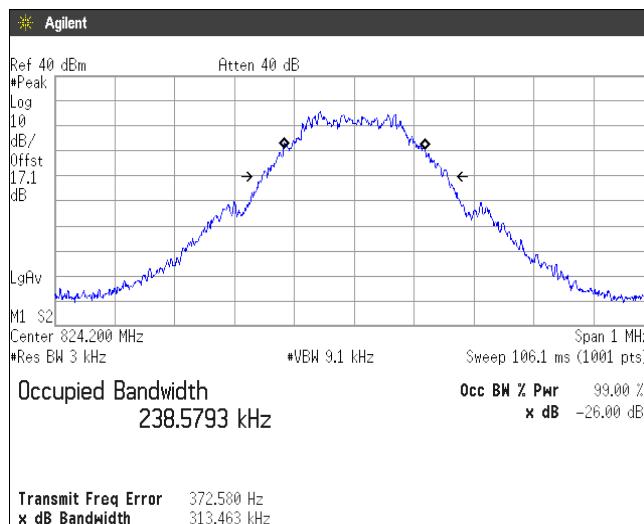
Test engineer :

Tadahiro Seino

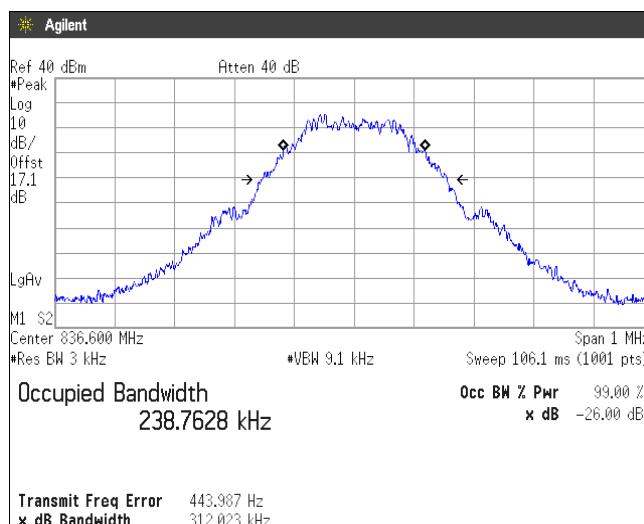
Band	Channel	Frequency (MHz)	Test Result (kHz)
GSM850	128	824.2	238.5793
	190	836.6	238.7628
	251	848.8	239.3272
WCDMA Band V	4132	826.4	4137.2
	4183	836.6	4120.7
	4233	846.6	4121.1

5.4 Trace data [GSM850]

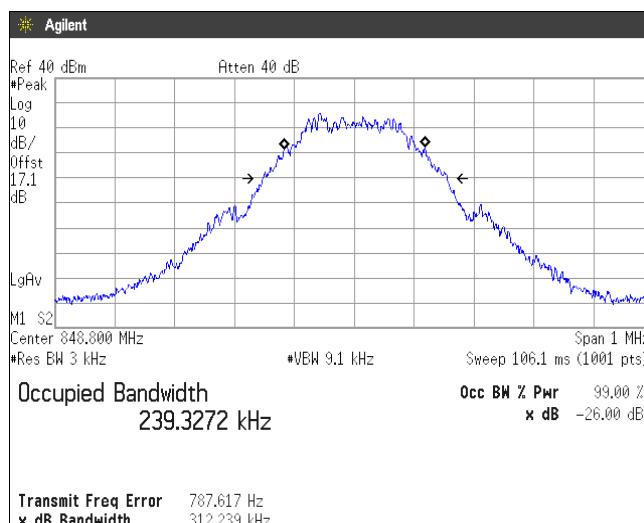
Channel: 128

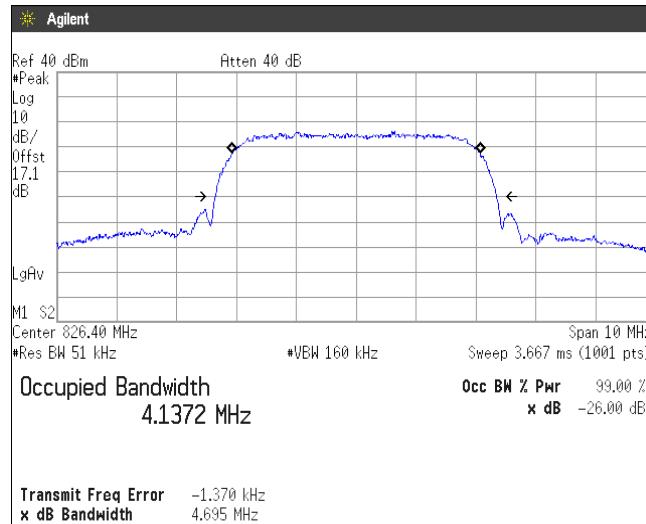
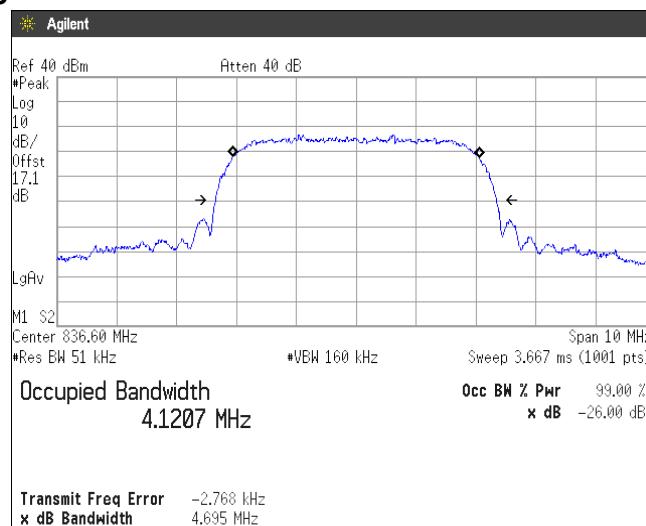
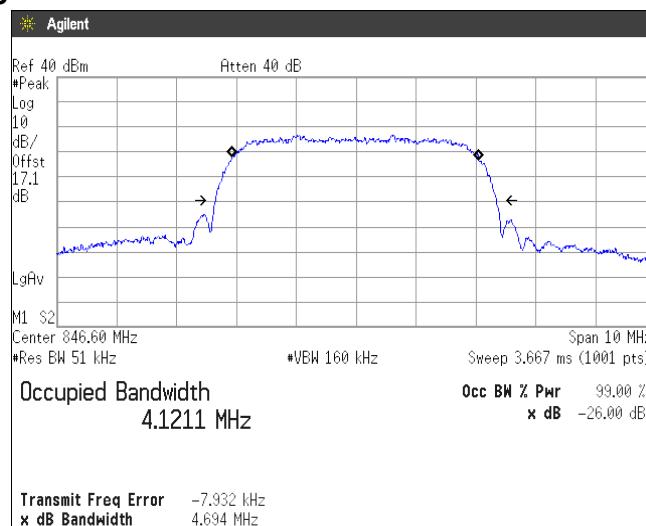


Channel: 190



Channel: 251



[WCDMA Band V]
Channel: 4132

Channel: 4183

Channel: 4233


6. Band Edge Spurious and Harmonic at Antenna Terminals

6.1 Measurement procedure

[FCC 22.917(a), 2.1051]

The band edge spurious and harmonic was measured with a spectrum analyzer connected to the antenna terminal.

The spectrum analyzer is set to;

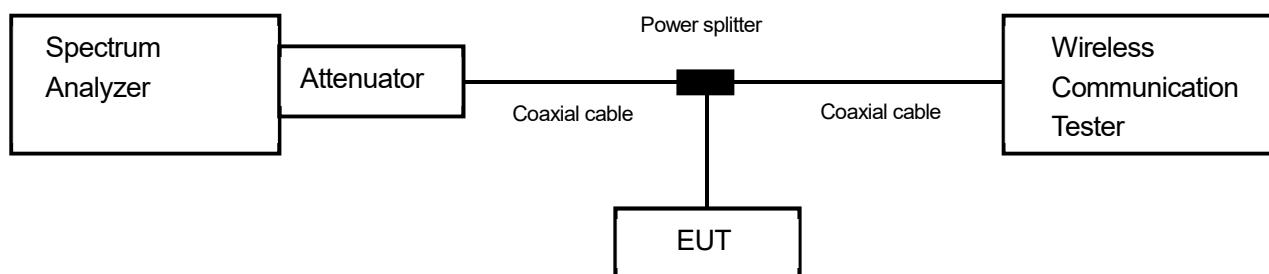
<Band Edge>

- a) Span was set large enough so as to capture all out of band emissions near the band edge
- b) RBW \geq 1% of the emission bandwidth or 2% of the emission bandwidth
- c) VBW \geq 3 x RBW
- d) Detector = RMS
- e) Trace mode = Max hold
- f) Sweep time = auto-couple
- g) Number of sweep point \geq 2 x span / RBW

<Spurious Emissions>

- a) RBW = 1MHz & VBW \geq 3 x RBW
- b) Detector = Peak
- c) Trace mode = Max hold
- d) Sweep time = auto-couple
- e) Number of sweep point \geq 2 x span / RBW

- Test configuration



6.2 Limit

-13dB or less

6.3 Measurement result

Date : August 3, 2018
 Temperature : 24.9 [°C]
 Humidity : 54.1 [%]
 Test place : Shielded room No.4

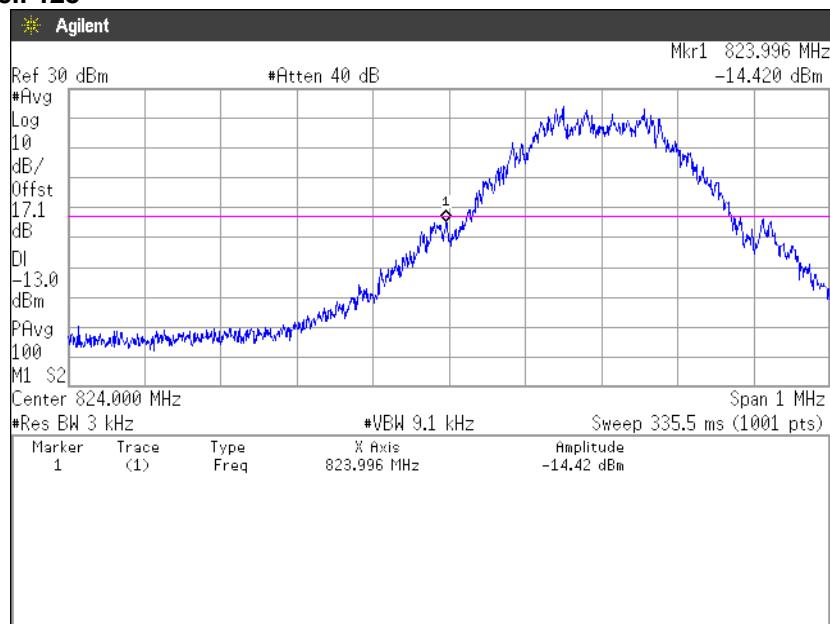
Test engineer : Tadahiro Seino

Band	Channel	Frequency [MHz]	Limit [dB]	Results	
GSM850	128	824.2	-13.0	See the trace data	PASS
	190	836.6	-13.0	See the trace data	PASS
	251	848.8	-13.0	See the trace data	PASS
WCDMA Band V	4132	826.4	-13.0	See the trace data	PASS
	4183	836.6	-13.0	See the trace data	PASS
	4233	846.6	-13.0	See the trace data	PASS

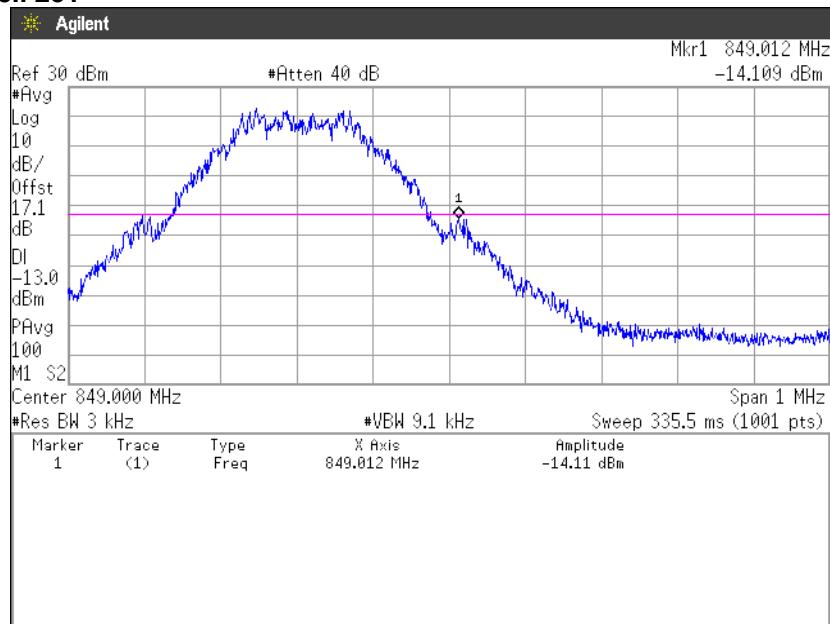
6.4 Trace data

[GSM850]
(Band Edge)

Channel: 128



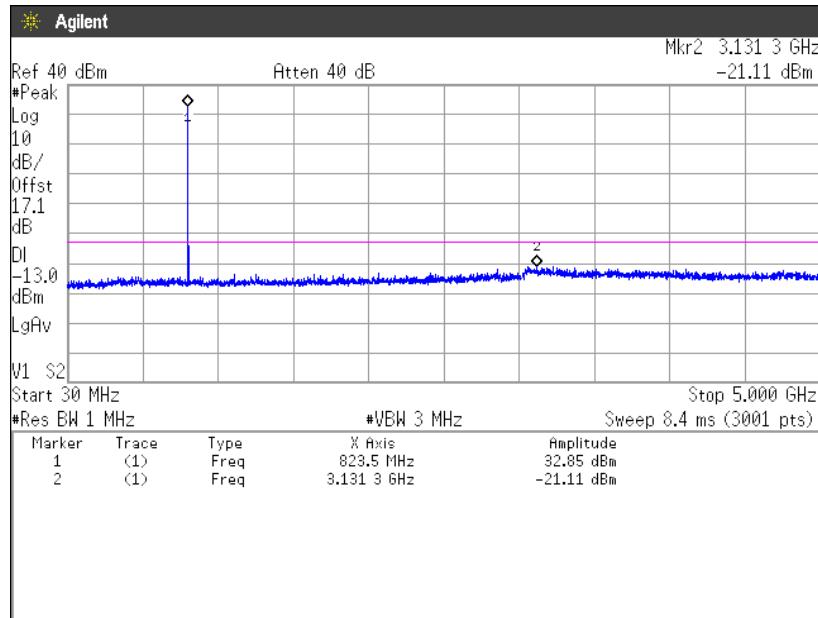
Channel: 251



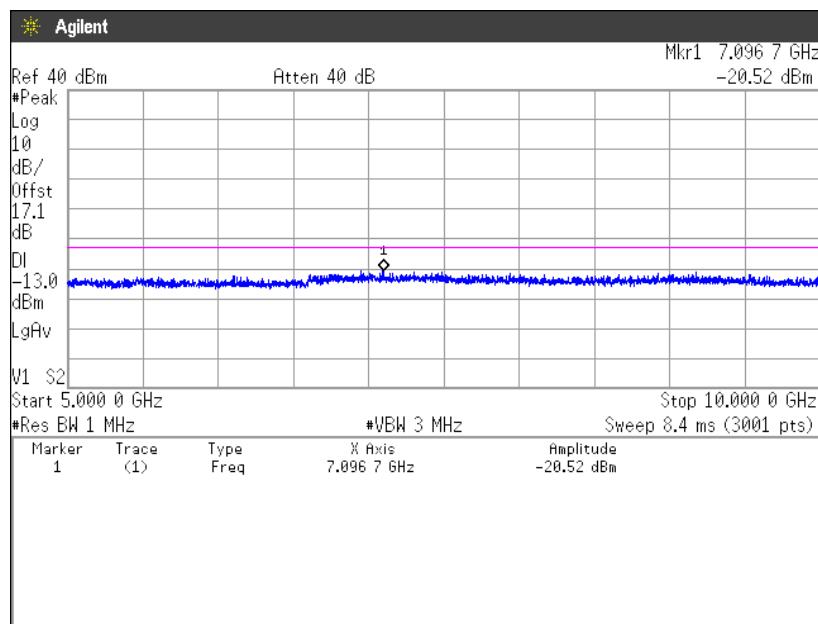
(Spurious Emissions)

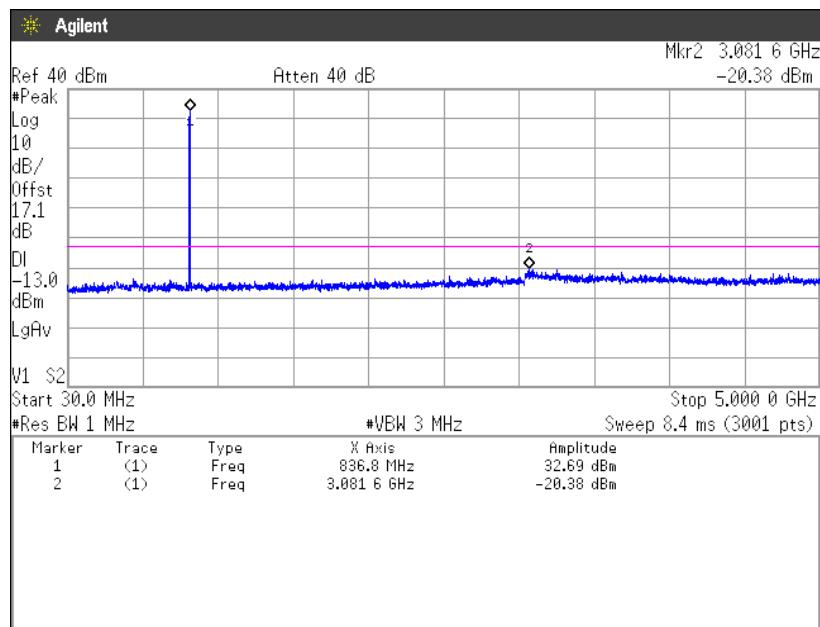
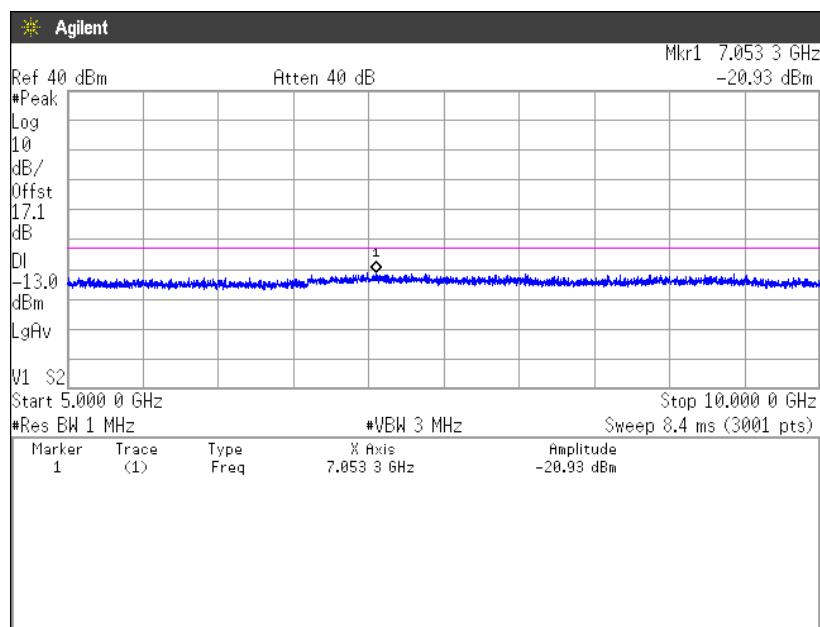
Note: Conducted spurious test was measured in the worst case of conducted output power.

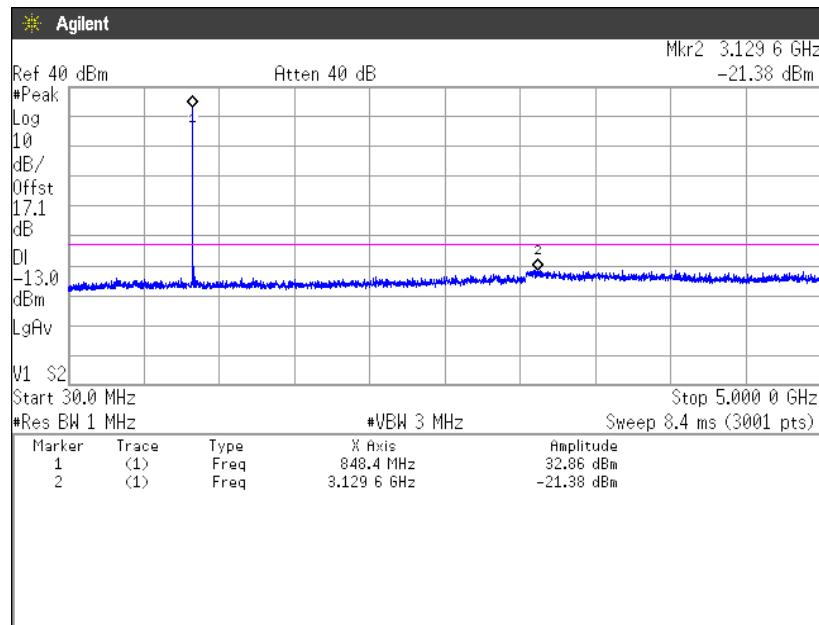
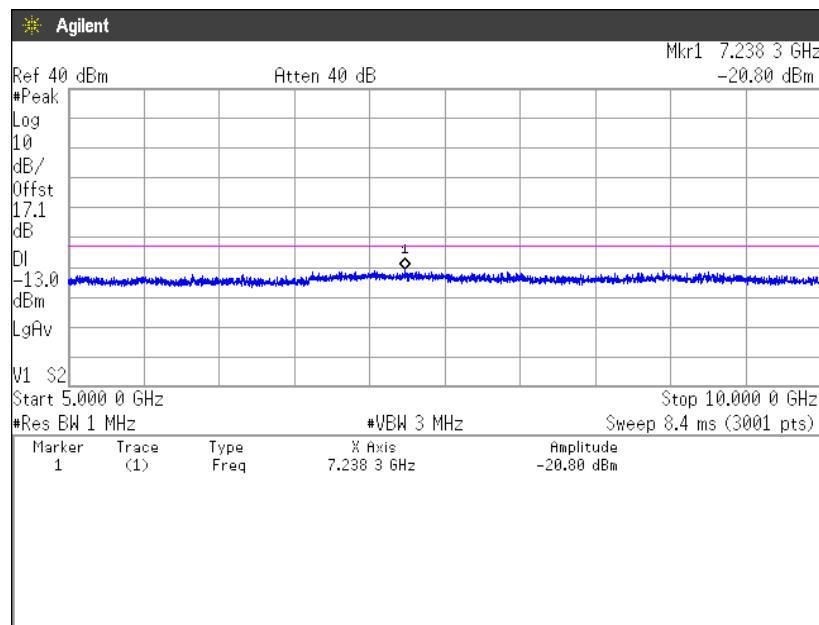
Channel: 128
30MHz-5GHz



5GHz-10GHz



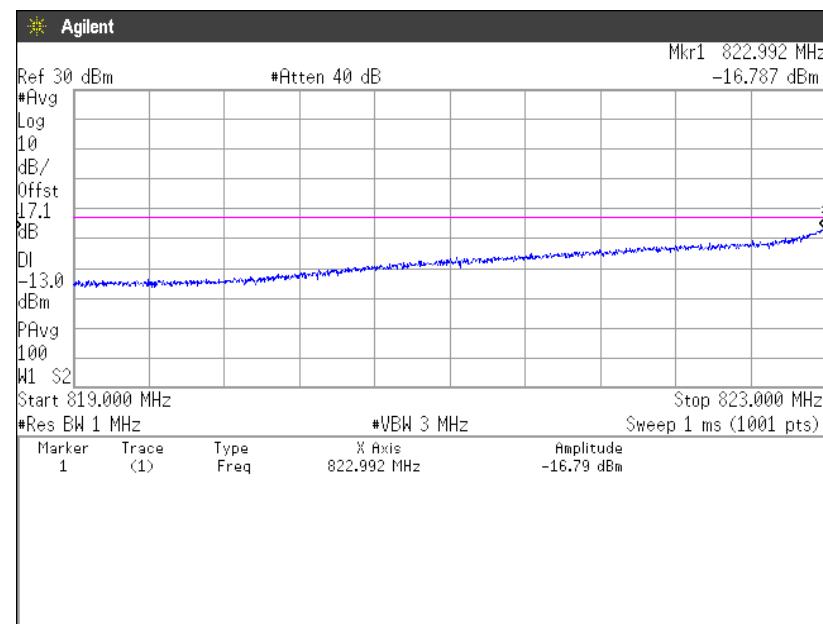
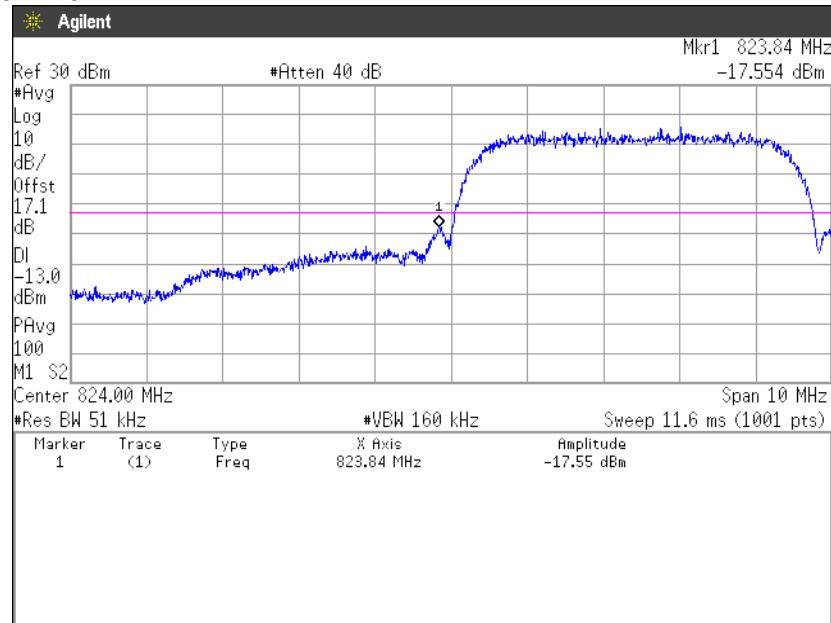
Channel: 190
30MHz-5GHz

5GHz-10GHz


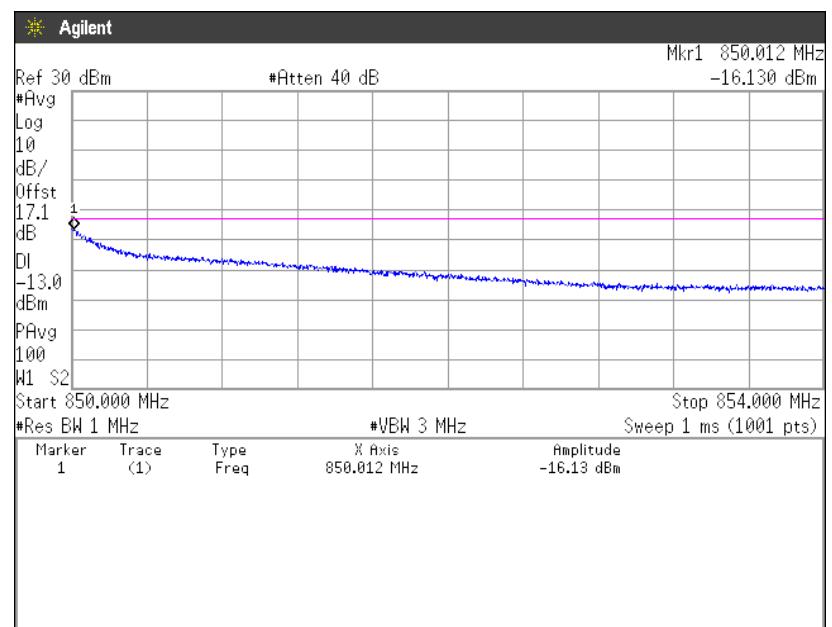
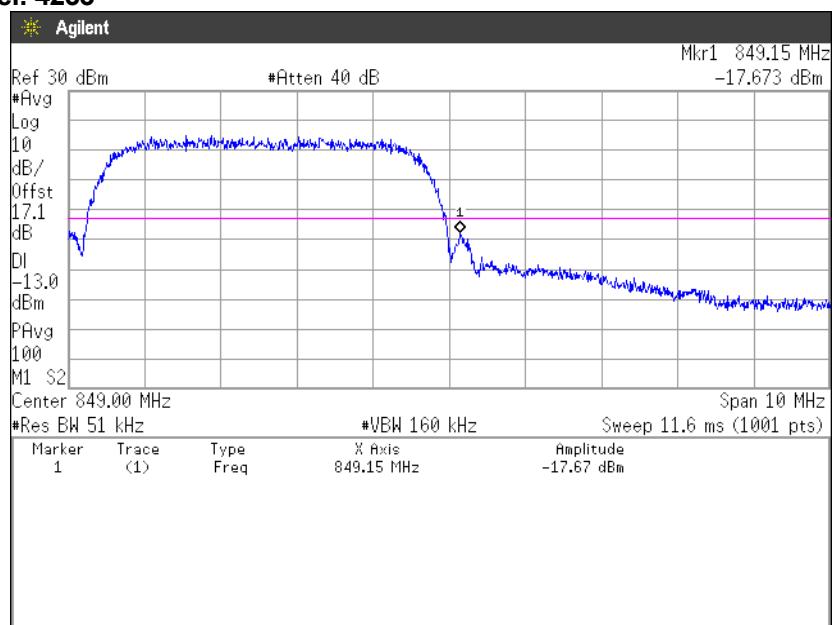
Channel: 251
30MHz-5GHz

5GHz-10GHz


[WCDMA Band V]

(Band Edge)

Channel: 4132

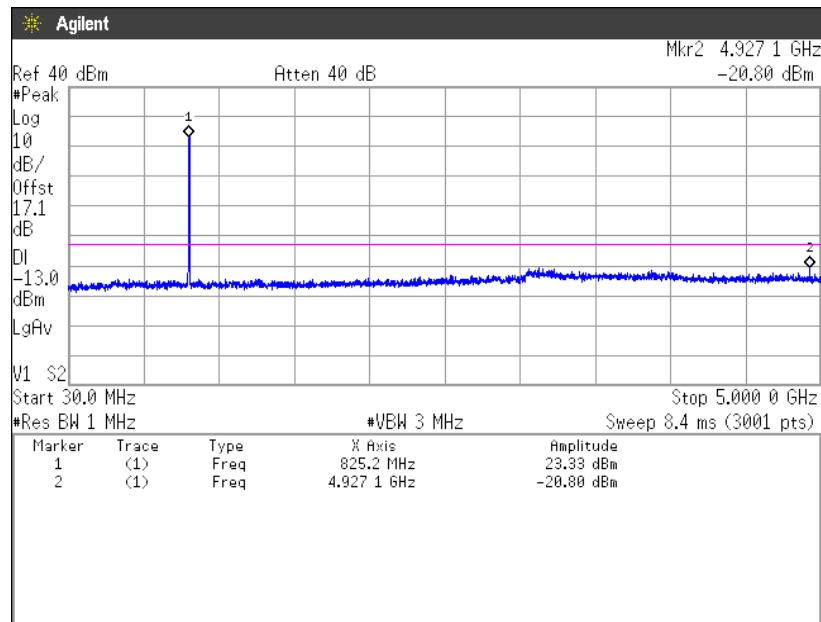
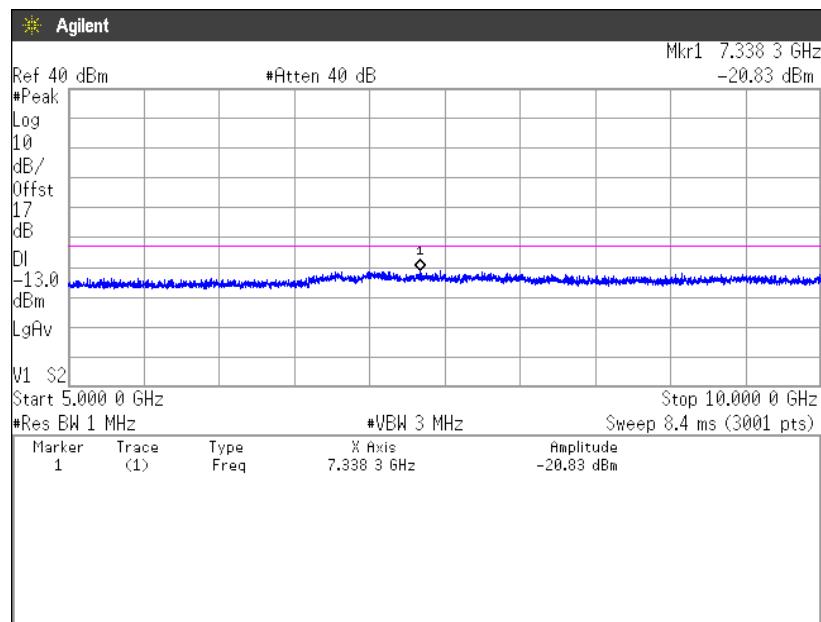


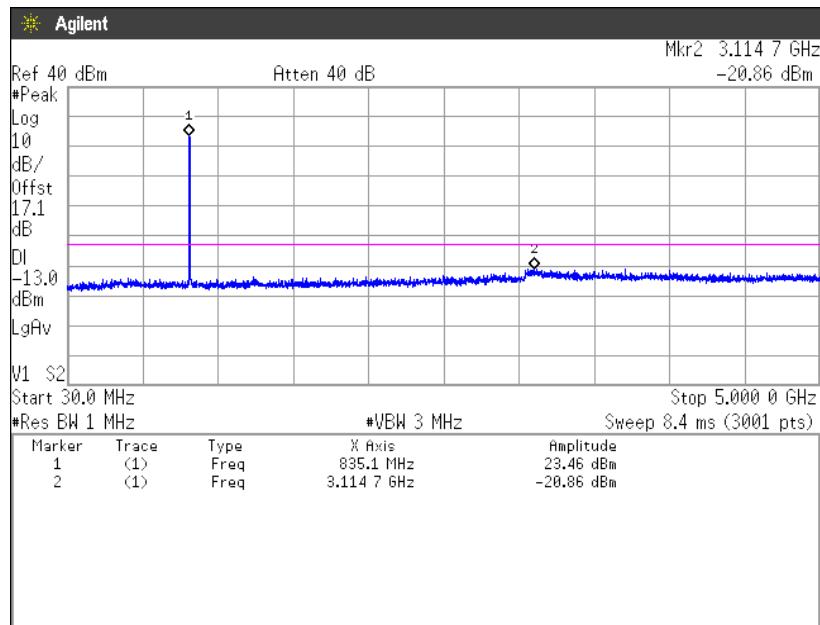
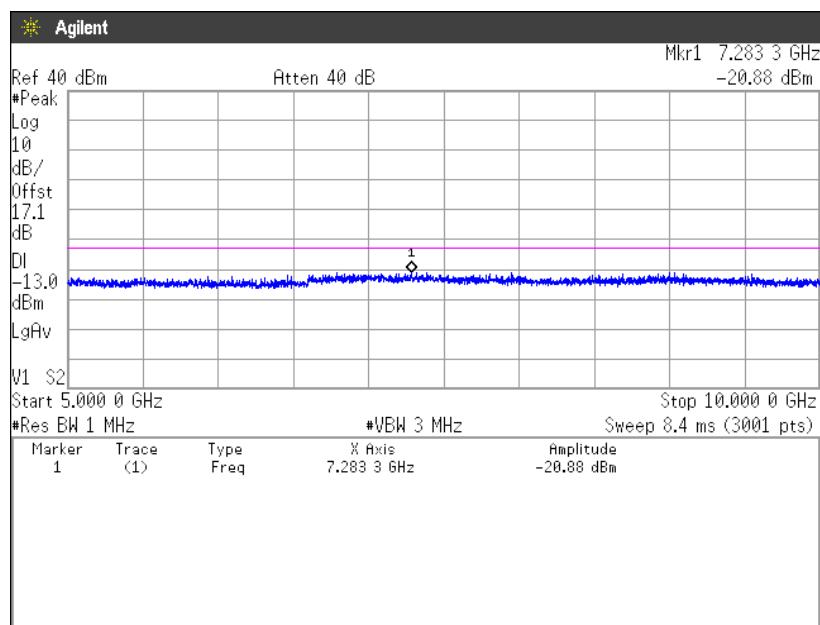
Channel: 4233

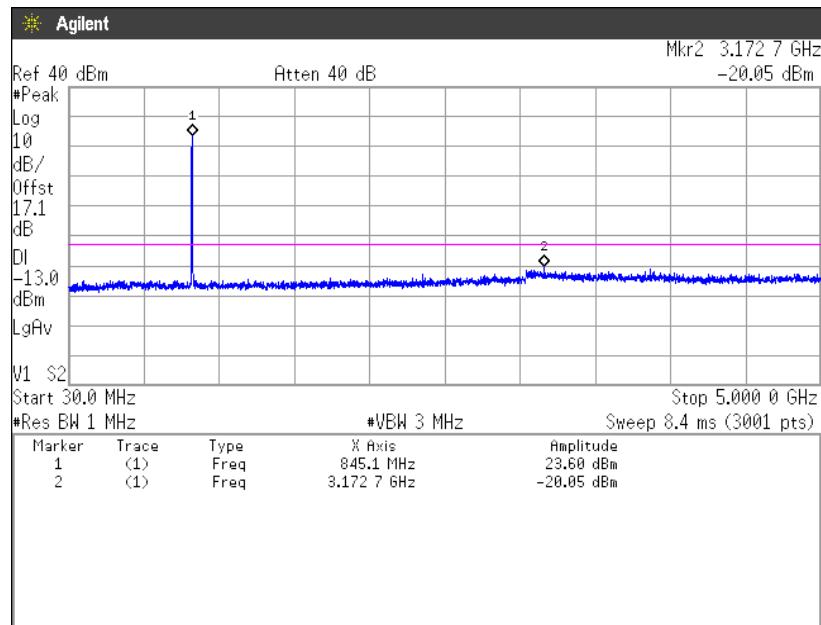
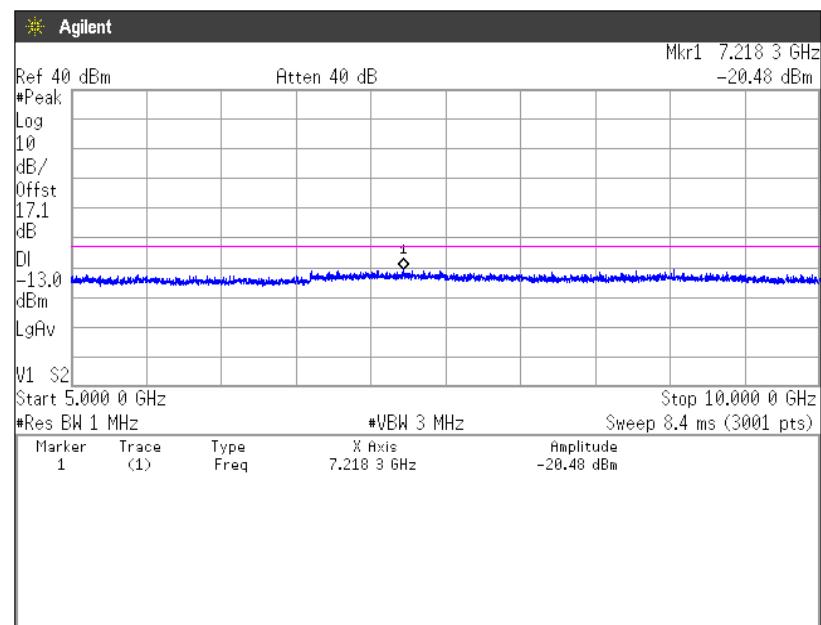
(Spurious Emissions)

Note: Conducted spurious test was measured in the worst case of conducted output power.

Channel: 4132
30MHz-5GHz

**5GHz-10GHz**

Channel: 4183
30MHz-5GHz

5GHz-10GHz


Channel: 4233
30MHz-5GHz

5GHz-10GHz


7. Radiated Emissions and Harmonic Emissions

7.1 Measurement procedure

[FCC 22.917(a), 2.1053]

<Step 1>

The EUT and support equipment are placed on a 1 meter x 1 meter surface, 0.8 meter height styrene foam table. Radiated emission measurements are performed at 3 meter distance with the broadband antenna (Biconical antenna, Log periodic antenna and double ridged guide antenna). The antenna is positioned both the horizontal and vertical planes of polarization and height is varied 1 to 4 meters and stopped at height producing the maximum emission.

The bandwidth of the spectrum analyzer is set to 1MHz. The turntable is rotated by 360 degrees and stopped at azimuth of producing the maximum emission. The frequency is investigated up to 20GHz.

<Step 2>

The substitution antenna is replaced by the transmitter antenna (EUT).

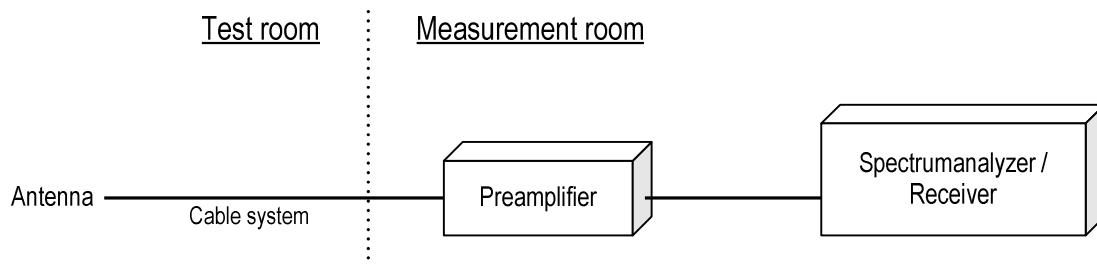
The frequency of the signal generator is adjusted to the measurement frequency.

Level of the signal generator is adjusted to the level that is obtained from step 1, and record the emission level of signal generator.

The spectrum analyzer is set to:

- a) RBW = 100kHz for below 1GHz and 1MHz for above 1GHz / VBW $\geq 3 \times$ RBW
- b) Detector = Peak
- c) Trace mode = Max hold
- d) Sweep time = auto-couple

- Test configuration



7.2 Calculation method

Result (ERP) = Ant. Input - Cable loss + Antenna Gain

Margin = Limit – Result (ERP)

Example:

Limit @ 1648.4MHz : -13.0dBm

Ant. Input = -56.4dBm Cable loss = 1.0dB Ant. Gain = 6.9dBd

Result = $-56.4 - 1.0 + 6.9 = -50.6\text{dBm}$

Margin = $-13.0 - (-50.6) = 37.6\text{dB}$

7.3 Limit

-13dBm or less

7.4 Test data

Date	:	August 2, 2018		
Temperature	:	24.3 [°C]	Test engineer	
Humidity	:	51.6 [%]		<u>Taiki Watanabe</u>
Test place	:	3m Semi-anechoic chamber		
Date	:	August 20, 2018		
Temperature	:	25.6 [°C]	Test engineer	
Humidity	:	44.1 [%]		<u>Taiki Watanabe</u>
Test place	:	3m Semi-anechoic chamber		
Date	:	August 22, 2018		
Temperature	:	22.1 [°C]	Test engineer	
Humidity	:	52.5 [%]		<u>Taiki Watanabe</u>
Test place	:	3m Semi-anechoic chamber		
Date	:	August 23, 2018		
Temperature	:	20.3 [°C]	Test engineer	
Humidity	:	50.8 [%]		<u>Taiki Watanabe</u>
Test place	:	3m Semi-anechoic chamber		
Date	:	August 24, 2018		
Temperature	:	23.6 [°C]	Test engineer	
Humidity	:	53.6 [%]		<u>Tadahiro Seino</u>
Test place	:	3m Semi-anechoic chamber		
Date	:	August 28, 2018		
Temperature	:	22.4 [°C]	Test engineer	
Humidity	:	67.2 [%]		<u>Tadahiro Seino</u>
Test place	:	3m Semi-anechoic chamber		

[GSM850]**(Channel: 128)**

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1648.4	-55.5	-68.7	1.1	11.1	-58.7	-13.0	45.7
H	2472.6	-55.4	-67.9	1.3	11.9	-57.4	-13.0	44.4

(Channel: 190)

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1673.2	-54.9	-65.5	1.1	11.0	-55.6	-13.0	42.6
H	2509.8	-53.6	-55.2	1.3	11.9	-44.6	-13.0	31.6

(Channel: 251)

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1697.6	-55.1	-67.0	1.1	10.8	-57.3	-13.0	44.3
H	2546.4	-53.5	-55.0	1.3	11.9	-44.4	-13.0	31.4

[WCDMA Band V]**(Channel: 4132)**

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1652.8	-56.0	-75.0	1.1	11.1	-65.0	-13.0	52.0

(Channel: 4183)

H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1673.2	-55.9	-74.7	1.1	11.0	-64.8	-13.0	51.8

(Channel: 4233)

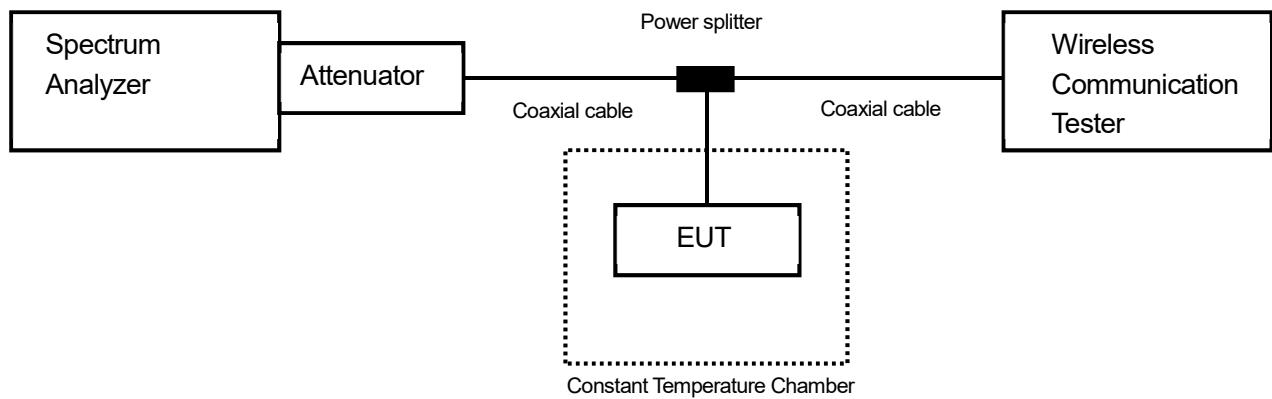
H/V	Frequency [MHz]	S.A Reading [dBm]	Ant. Input [dBm]	Cable loss [dB]	Ant.Gain [dBd]	Result [dBm]	Limit [dBm]	Margin [dB]
H	1693.2	-56.2	-75.3	1.1	10.9	-65.5	-13.0	52.5

8. Frequency Stability

8.1 Measurement procedure [FCC 22.355, 2.1055]

The EUT was placed of an inside of an constant temperature chamber as the temperature in the chamber was varied between -30°C and +50°C. The temperature was incremented by 10°C intervals and the unit was allowed to stabilize at each measurement. The frequency drift was measured with the normal Temperature and voltage tolerance and it is presented as the ppm unit.

- Test configuration



8.2 Limit

$\pm 2.5\text{ppm}$

8.3 Measurement result

Date : August 20, 2018
 Temperature : 25.6 [°C]
 Humidity : 44.1 [%]
 Test place : Shielded room No.4

Test engineer : Tadahiro Seino

[GSM850]

(Channel: 190)

Limit: ±0.00025% = ±2.5ppm						
Power Supply [V]	Temperature [°C]	Measurements Frequency [Hz]	Frequency Tolerance [ppm]	Limit [ppm]	Result	
3.80	25(Ref.)	836,600,018	0.00000	±2.5	Pass	
	50	836,600,022	0.00417	±2.5	Pass	
	40	836,600,018	0.00004	±2.5	Pass	
	30	836,600,017	-0.00139	±2.5	Pass	
	20	836,600,017	-0.00152	±2.5	Pass	
	10	836,600,016	-0.00235	±2.5	Pass	
	0	836,600,018	-0.00085	±2.5	Pass	
	-10	836,600,019	0.00128	±2.5	Pass	
	-20	836,600,033	0.01752	±2.5	Pass	
	-30	836,600,038	0.02327	±2.5	Pass	
3.42	25	836,600,019	0.00104	±2.5	Pass	
4.18	25	836,600,021	0.00267	±2.5	Pass	

[WCDMA Band V]

(Channel: 4183)

Limit: ±0.00025% = ±2.5ppm						
Power Supply [V]	Temperature [°C]	Measurements Frequency [Hz]	Frequency Tolerance [ppm]	Limit [ppm]	Result	
3.80	25(Ref.)	836,599,996	0.00000	±2.5	Pass	
	50	836,600,002	0.00791	±2.5	Pass	
	40	836,600,004	0.00932	±2.5	Pass	
	30	836,599,997	0.00104	±2.5	Pass	
	20	836,600,001	0.00602	±2.5	Pass	
	10	836,599,999	0.00409	±2.5	Pass	
	0	836,599,997	0.00097	±2.5	Pass	
	-10	836,600,002	0.00694	±2.5	Pass	
	-20	836,600,003	0.00902	±2.5	Pass	
	-30	836,600,004	0.00956	±2.5	Pass	
3.42	25	836,599,995	-0.00055	±2.5	Pass	
4.18	25	836,600,003	0.00810	±2.5	Pass	

Calculation;

Frequency Tolerance (ppm) = Measurements Frequency (Hz) – Reference Frequency (Hz) / Reference Frequency (Hz) × 1000000

9. Uncertainty of measurement

Expanded uncertainties stated are calculated with a coverage Factor k=2.

Please note that these results are not taken into account when determining compliance or non-compliance with test result.

Test item	Measurement uncertainty
Conducted emission, AMN (9kHz – 150kHz)	±3.8dB
Conducted emission, AMN (150kHz – 30MHz)	±3.3dB
Radiated emission (9kHz – 30MHz)	±3.0dB
Radiated emission (30MHz – 1000MHz)	±4.7dB
Radiated emission (1GHz – 6GHz)	±4.9dB
Radiated emission (6GHz – 18GHz)	±5.2dB
Radiated emission (18GHz – 40GHz)	±5.8dB

10. Laboratory Information

1. Location

Testing done by September 30th, 2018 was performed at:

Name: TÜV SÜD Zacta Ltd. Yonezawa Testing Center
 Address: 5-4149-7, Hachimanpara, Yonezawa-shi, Yamagata, 992-1128 Japan
 Phone: +81-238-28-2881
 Fax: +81-238-28-2888

Testing done after October 1st, 2018 was performed and the test report was issued at:

Name: TÜV SÜD Japan Ltd. Yonezawa Testing Center
 Address: 5-4149-7, Hachimanpara, Yonezawa-shi, Yamagata, 992-1128 Japan
 Phone: +81-238-28-2881
 Fax: +81-238-28-2888

2. Accreditation and Registration

1) VLAC

Accreditation No.: VLAC-013

2) NVLAP

LAB CODE: 200306-0

3) BSMI

Laboratory Code: SL2-IN-E-6018, SL2-A1-E-6018

4) Industry Canada

Site number	Facility	Expiration date
4224A-4	3m Semi-anechoic chamber	2020-11-27
4224A-5	10m Semi-anechoic chamber No.1	2020-11-27
4224A-6	10m Semi-anechoic chamber No.2	2019-12-14

5) VCCI Council

Registration number	Expiration date
A-0166	2019-07-03

Appendix A. Test equipment

Antenna port conducted test

Equipment	Company	Model No.	Serial No.	Cal. Due	Cal. Date
Spectrum analyzer	Agilent Technologies	E4440A	US44302655	Jul. 31, 2019	Jul. 2, 2018
Attenuator	HUBER+SUHNER	6810.19.A	N/A(S450)	Jan. 31, 2019	Jan. 18, 2018
Microwave cable	HUBER+SUHNER	SUCOFLEX 104	199119/4	Dec. 31, 2018	Dec. 6, 2017
Power divider	ANRITSU	K240B	020205	Jul. 31, 2019	Jul. 12, 2018
Wideband Radio Frequency Tester	ROHDE&SCHWARZ	CMW500	126079	Oct. 31, 2018	Oct. 13, 2017
Low temperature and humidity chamber	ESPEC	PL1KP	14007261	Dec. 31, 2018	Dec. 20, 2017

Radiated emission

Equipment	Company	Model No.	Serial No.	Cal. Due	Cal. Date
EMI Receiver	ROHDE&SCHWARZ	ESCI	100765	Sep. 30, 2018	Sep. 13, 2017
Spectrum analyzer	Agilent Technologies	E4440A	US40420937	Oct. 31, 2018	Oct. 19, 2017
Preamplifier	SONOMA	310	372170	Sep. 30, 2018	Sep. 12, 2017
Biconical antenna	Schwarzbeck	VHA9103/BBA9106	2155	Aug. 31, 2019	Aug. 6, 2018
Log periodic antenna	Schwarzbeck	UHALP9108A	0560	Aug. 31, 2019	Aug. 6, 2018
Attenuator	TME	CFA-01NPJ-6	N/A(S275)	Jan. 31, 2019	Jan. 18, 2018
Attenuator	TME	CFA-01NPJ-3	N/A(S272)	Jan. 31, 2019	Jan. 18, 2018
Preamplifier	TSJ	MLA-100M18-B02-40	1929118	Jan. 31, 2019	Jan. 18, 2018
Attenuator	AEROFLEX	26A-10	081217-08	Jan. 31, 2019	Jan. 18, 2018
Double ridged guide antenna	ETS LINDGREN	3117	00052315	Mar. 31, 2019	Mar. 14, 2018
Attenuator	Agilent Technologies	8491B	MY39268633	Mar. 31, 2019	Mar. 14, 2018
Double ridged guide antenna	A.H.Systems Inc.	SAS-574	469	Aug. 31, 2018	Aug. 8, 2017
				Aug. 31, 2019	Aug. 24, 2018
Preamplifier	TSJ	MLA-1840-B03-35	1240332	Aug. 31, 2018	Aug. 8, 2017
				Aug. 31, 2019	Aug. 24, 2018
Notch Filter	Micro-Tronics	BRM50706	003	Jul. 31, 2018	Jul. 12, 2018
High Pass Filter	Wainwright	WHKX2.8/18G-6SS	1	Jul. 31, 2019	Jul. 12, 2018
Signal generator	ROHDE&SCHWARZ	SMB100A	177525	Jul. 31, 2019	Jul. 31, 2018
RF power amplifier	R&K	CGA020M602-2633R	B40240	May 31, 2019	May 17, 2018
Microwave cable	HUBER+SUHNER	SUCOFELX102/2m	31648	Mar. 31, 2019	Mar. 1, 2018
Dipole antenna	Schwarzbeck	VHAP	1020	Aug. 31, 2019	Aug. 3, 2018
Dipole antenna	Schwarzbeck	UHAP	994	Aug. 31, 2019	Aug. 3, 2018
Double ridged guide antenna	EMCO	3115	00058532	Jan. 31, 2019	Jan. 18, 2018
Wideband Radio Frequency Tester	ROHDE&SCHWARZ	CMW500	126079	Oct. 31, 2018	Oct. 13, 2017
		SUCOFLEX104/9m	MY30037/4	Jan. 31, 2019	Jan. 18, 2018
		SUCOFLEX104/1m	my24610/4	Jan. 31, 2019	Jan. 18, 2018
		SUCOFLEX104/8m	SN MY30031/4	Jan. 31, 2019	Jan. 18, 2018
		SUCOFLEX104	MY32976/4	Jan. 31, 2019	Jan. 18, 2018
		SUCOFLEX104/1.5m	SN MY19309/4	Jan. 31, 2019	Jan. 19, 2018
		SUCOFLEX104/7m	41625/6	Jan. 31, 2019	Jan. 19, 2018
PC	DELL	DIMENSION E521	75465BX	N/A	N/A
Software	TOYO Corporation	EP5/RE-AJ	0611193/V5.6.0	N/A	N/A
Absorber	RIKEN	PFP30	N/A	N/A	N/A
3m Semi an-echoic Chamber	TOKIN	N/A	N/A(9002-NSA)	May 31, 2019	May 21, 2018
3m Semi an-echoic Chamber	TOKIN	N/A	N/A(9002-SVSWR)	May 31, 2019	May 22, 2018

*: The calibrations of the above equipment are traceable to NIST or equivalent standards of the reference organizations.